



SE-RAY-RCS



ADVANCED RCS COMPUTATION TOOL



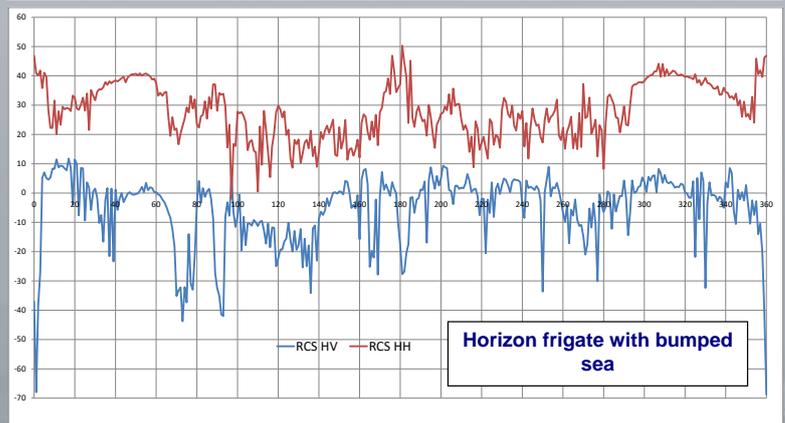
SE-RAY-RCS is a dedicated declination of the SE-RAY-EM software accessible through the user friendly SE-SCENARIO environment. It enables the calculation of complex target's RCS which 3D mock-up can be up to several million polygons.

Features

- RF models validated by ONERA in France, FOI in Sweden and Fraunhofer FHR in Germany
- Very efficient computation kernel, even for very complex objects described by a several million polygons CAD model
- Can compute objects coated with dielectric layers including diffraction by edges
- Can deal with almost all popular CAD formats thanks to its associated 3ds Max[®] and Sketchup[®] plug-ins
- Easy-to-use product thanks to its dedicated GUI
- Validated model: validated results against testing campaigns

Key Advantages

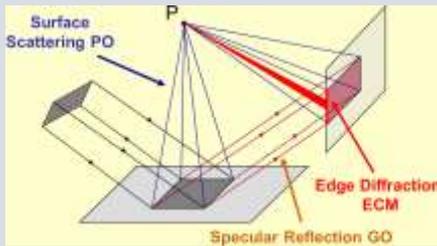
- Complex 3D objects with multi-materials and multi layered materials (each layer being defined by its characteristics ϵ , ϵ' , σ and its thickness)
- Complex 3D environment including foliage masking, bumped terrains, sea effect, other targets interaction...
- Multi frequencies computation
- Mono-static and multi-static configuration
- Multiple reflections of rays to order N
- Polarisation in emission and reception





Benefits

- RF formulations validated by ONERA
- Coupling between the target and its environment



- A simpler and fast RCS computation is also accessible through an EXCEL™ spreadsheet.

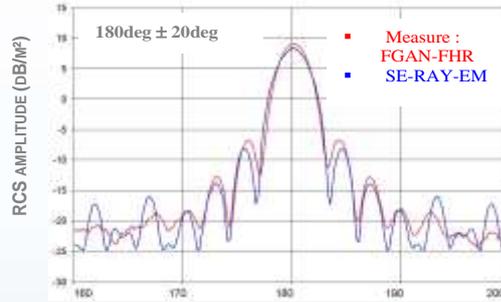
Source parameters	
Frequency	10 GHz
Polarization	<input checked="" type="radio"/> Theta (V) <input type="radio"/> Phi (H)
Computation parameters	
RCS polarization	<input checked="" type="checkbox"/> Theta (V) <input type="checkbox"/> Phi (H)
RCS distance computation	10000,00m
Primary grid resolution	5,00E-02m
Antialiasing level	5
Antialiasing grid resolution	1,56E-03m
Normal angle vector	5,0°
Output relative path	/
Output base filename	pp
Computation Model	EMmulti EMmono
RCS trajectory	
Spin axis	<input type="radio"/> X axis <input checked="" type="radio"/> Y axis <input type="radio"/> Z axis
Beginning attitude	-50,0°
Ending attitude	50,0°
Elevation	0,0°
Angle sampling	1,0°
Target	
Filename	dihed100.bdd
Environment	
Data Path	/

System requirements



Virtual mockup of the measured object

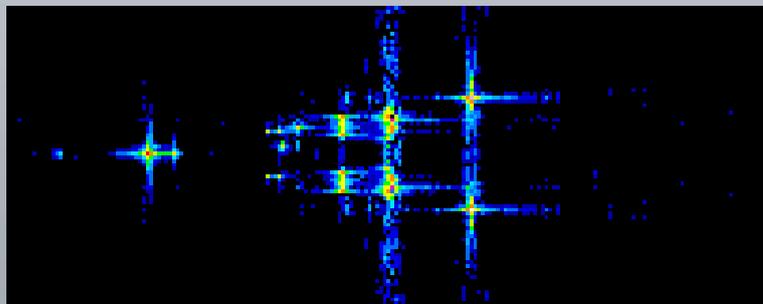
Measured object provided by FGAN



Physical Model Features

- Association of shooting and bouncing ray technique (ray tracing) & electromagnetic asymptotic formulations
- Scattering computation using Physical Optics
- Multiple reflections computation using Geometrical Optics
- Edge diffraction computation using the Equivalent Current Method of Michaeli extended to targets covered by dielectric materials
- Geometrical divergence in GO reflection computation
- Reflection and scattering on multilayer dielectric materials
- Based on multi-frequencies and multi-angles RCS computation, ISAR images can be computed

ISAR image



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